Benchmarking Diagnostic Algorithms on an Electrical Power System Testbed

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System and Methodology

Aspect

ADAPT-Lite ADAPT









Performance Metrics

QSI

Integrated Vehicle Health Management Project

Name	Description	Class/Category											
"Per System Description" Metrics													
False Positives Rate	Spurious faults rate	Technical / Detection											
False Negatives Rate	Missed faults rate	Technical / Detection											
Detection Accuracy	Correctness of the detection	Technical / Detection											
"Per Scenario" Metrics													
Fault Detection Time	Time for detecting a fault	Temporal / Detection											
Fault Isolation Time	Time for last persistent diagnosis	Temporal / Isolation											
Classification Errors	Number of mode classification errors	Technical / Isolation											
CPU Load	CPU time spent	Computational / Detection & Isolation											
Memory Load	Memory allocated	Computational / Detection & Isolation											

Results

Diagno	stic A	Igorithms		DAP	T-Lite	(AL)				-	-	-				ADAPT	Г (А)								<u>[</u>	<u>Discussion</u>
Name	System	Algorithm Type			FACT B	ault uster Hy	yDE-A H	yDE-S	Lydia	NGDE	Pro ADAPT	Racer		N Rules Rule	³ Wizards		Fault Buster	Goal Art	HyDE	Lydia	Pro ADAPT	RODON	Stanford	Wizards		 Charts are for system ADAPT
FACT	AL	Model-based		FP Rate	0.109 C).011 0	0.000	0.380	0.011	0.033	0.011	0.033	0.01	1 0.326	0.000	FP Rate	0.0252	0.0314	0.0000	0.2453	0.0881	0.0000	0.1698	0.1635		(ADAPT-Lite results shown in
Fault Buster	A, AL	Statistical		FN Rate Det Acc	0.000 0 0.891 (0.500 0 0.891 0	0.464 (0.685	0.036 0.717	0.179 0.598	0.125 0.880	0.054 0.957	0.196	0.036	6 0.089 0.620	0.500	FN Rate Det Acc	0.3874 0.7044	0.0541	0.3063	0.1982 0.6164	0.0180 0.8994	0.0270 0.9811	0.0541	0.0901		table only)
GoalArt	A	Flow-models	Clas T_	s Errors det (ms)	44.500 1 1785	1.000561551	6.000 4 3355	15.026 121	66.000 232	100.348 194	10.000 4732	56.000 77	4.000 4204	63.000 949) 43.000 12202	Class Errors T_det (ms)	193.0 21255	154.0 3268	174.3 15612	234.9 16135	57.0 1743	75.6 5543	176.6 3826	209.2 25695		• ADAPT-Lite: single faults, no
HyDE-A	A, AL	Model-based	т_ С	iso (ms) PU (ms)	10798 99 15815	<u>)99999 1</u> ; 1951 2	3841 3418	683 573	232 1410	14922 21937	7104 1905	999999 146) <u>1236</u> 1205	4 949 0 167	12327 1153	T_iso (ms) CPU (ms)	9999999 10051	7505 149	18923 28807	16135 5715	19876 4260	30779 85331	14226 1012	45441 17111	-	nominal transitions
HyDE-S	AL	Model-based	Ν	lem (kb)	4271 2	2569 5	5511	5366	1861	73031	1226	3619	2887	0 3784	1682	Mem (kb)	7119	6784	19135	3412	778	31459	2213	3390	<u>-</u> •	ADAPT: includes multiple
Lydia	A, AL	Model-based	A	DAP	<mark>۲ Sce</mark>	nario	Brea	akdo	wn			100000 90000						שן	80000			_				simultaneous or sequential faults, nominal transitions
NGDE	AL	Model-based	19 t	riple-fau	lt scenaric	os (12%)		41	double-	fault	โล	80000 - 70000 -						o	70000 + 9 60000 +							No DA ranked first or second
ProADAPT	A, AL	Probabilistic		4				sce		20%)	00	(j) 60000						ati	or RAM							for all metrics
RacerX	AL	Change detection	ı								Ц	≝ 40000 −					■T_det	ut	(m) 40000				Mear	n CPU Time (ms) an Peak Memory		 Real-world system noise.
RODON	A, AL	Model-based									e E	30000			_			d	20000				Usag	;e (kb)		latencies, and transients
RulesRule	AL	Rule-based						ПП				10000					_	лo	10000			_ ↓ ┃ ↓ _ •				resulted in DA false positives
StanfordDA	А	Optimization	48 no	ominal parios		ашр							3uster DalArt	HyDE	Lydia DAPT	DDON Inford izards		Ŏ		uster balArt	HyDE Lydia	DDON	izards			



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